

Chopper-Stabilized Operational Amplifier (CSOA™)

FEATURES

■ Guaranteed Max. Offset	5μV
Guaranteed Max. Offset Drift	0.05μV/°C
■ Typ. Offset Drift	0.01 _μ V/°C
■ Excellent Long Term Stability	100nV/√Month
■ Guaranteed Max. Input Bias Current	30pA
Over Operating Temperature Range	
Guaranteed Min. Gain	120dB
<i>Guar<mark>anteed</mark></i> Min. CMRR	120dB
Guaranteed Min. PSRR	120dB
Single Supply Operation	4.75V to 16V
(Input Voltage Range Extends to Gro	und)
 External Capacitors can be Returned to 	o V - with No

APPLICATIONS

Noise Degradation

- Thermocouple Amplifiers
- Strain Gauge Amplifiers
- Low Level Signal Processing
- Medical Instrumentation

DESCRIPTION

The LTC1052 is a low noise chopper-stabilized op amp (CSOA) manufactured using Linear Technology's enhanced LTCMOSTM silicon gate process. Chopper-stabilization constantly corrects offset voltage errors. Both initial offset and changes in the offset due to time, temperature and common-mode voltage are corrected. This, coupled with picoampere input currents, gives this amplifier unmatched performance.

Low frequency (1/f) noise is also improved by the chopping technique. Instead of increasing continuously at a 3dB/octave rate, the internal chopping causes noise to decrease at low frequencies.

The chopper circuitry is entirely internal and completely transparent to the user. Only two external capacitors are required to alternately sample and hold the offset correction voltage and the amplified input signal. Control circuitry is brought out on the 14-pin version to allow the sampling of the LTC1052 to be synchronized with an external frequency source.

The LTC1052CS is a direct replacement for the ICL7652 in surface mounted packages.

LTC1052 Noise Spectrum 160 /OLTAGE NOISE DENSITY (nV/ \/Hz) 120 100 80 60 40 20 0 0 100 300 400 500 FREQUENCY (Hz)

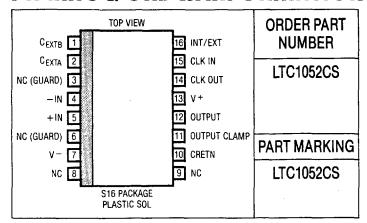
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ABSOLUTE MAXIMUM RATINGS

PACKAGE/ORDER INFORMATION

(Notes 1 and 2)

Total Supply Voltage (V^+ to V^-)	18V
Input Voltage(V+	+0.3V) to $(V0.3V)$
Output Short Circuit Duration	Indefinite
Operating Temperature Range	40°C to 85°C
Storage Temperature Range	
Lead Temperature (Soldering, 10 sec.)300°C



ELECTRICAL CHARACTERISTICS

 $V_S = \pm 15V$, $T_A =$ operating temperature range, test circuit TC1 (Note 6), unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS		MIN	LTC10520 TYP) MAX	UNITS
Vos	Input Offset Voltage	T _A = 25°C (Note 3)			±0.5	±5	μV
△V _{OS}	Average Input Offset Drift	(Note 3)	•		± 0.01	± 0.05	μV/°C
△V _{OS}	Long Term Offset Voltage Stability				100		nV/√Month
los	Input Offset Current	T _A = 25°C	•		±5	±30 ±350	pA pA
l _B	Input Bias Current	T _A = 25°C	•		±1	± 30 ± 175	pA pA
e _{np-p}	Input Noise Voltage	$R_S = 100\Omega$, DC to 10Hz, TC3 (Note 6) $R_S = 100\Omega$, DC to 1Hz, TC3 (Note 6)			1.5 0.5		μVp-p μVp-p
in	Input Noise Current	f = 10Hz (Note 5)			0.6		fA/√Hz
CMRR	Common-Mode Rejection Ratio	$V_{CM} = V^{-} \text{ to } + 2.7V$	•	120	140		dB
PSRR	Power Supply Rejection Ratio	$V_{SUPPLY} = \pm 2.375V \text{ to } \pm 8V$	•	120	150		dB
A _{VOL}	Large Signal Voltage Gain	$R_L = 10k$, $V_{OUT} = \pm 4V$	•	120	150		dB
V _{OUT}	Maximum Output Voltage Swing (Note 4)	R _L = 10k R _L = 100k	•	± 4.7	± 4.85 ± 4.95		V
SR	Slew Rate	$R_L = 10k, C_L = 50pF$			4		V/μs
GBW	Gain Bandwidth Product				1.2		MHz
Is	Supply Current	No Load, T _A = 25°C	•		1.7	2.0 3.0	mA mA
fs	Internal Sampling Frequency				330		Hz
	Clamp On Current	R _L = 100k	•	25	100		μА
	Clamp Off Current	- 4V < V _{OUT} < + 4V	•		10	100 1	pA nA

The ullet denotes specifications which apply over the full operating temperature range.

Note 1: Absolute Maximum Ratings are those values beyond which the life of the device may be impaired.

Note 2: Connecting any terminal to voltages greater than V^+ or less than V^- may cause destructive latch-up. It is recommended that no sources operating from external supplies be applied prior to power-up of the LTC1052.

Note 3: These parameters are guaranteed by design. Thermocouple effects preclude measurement of these voltage levels in high speed automatic

testing. V_{OS} is measured to a limit determined by test equipment capability. Voltages on C_{EXTA} and C_{EXTB} , A_{VOL} , CMRR and PSRR are measured to insure proper operation of the nulling loop to insure meeting the V_{OS} and V_{OS} drift specifications.

Note 4: Output clamp not connected.

Note 5: Current noise is calculated from the formula: $i_n = (2q l_B)^{\frac{1}{2}}$, where $q = 1.6 \times 10^{-19}$ coulomb.

Note 6: For description of test circuits see LTC1052 standard package data sheet.